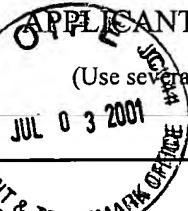


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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

<b>APPLICANT'S ART CITATION</b> <small>(Use several sheets if necessary)</small> 		Application 09/479,564		OFGS File No. P/3156-13								
		Applicant MIYATA, A.										
		Filing Date 1/7/00		Group Art Unit 2742								
<b>U.S. PATENT DOCUMENTS</b>												
Examiner Initials	Document Number				Date	Name	Class	Sub-class	Filing Date If Appropriate			
<b>FOREIGN PATENT DOCUMENTS</b>												
	Document Number				Date	Country	Class	Sub-class	Translation			
<i>EY</i>	2-	1	1	3	6	5	7	4/1990	JAPAN			X
<i>EY</i>	63-	3	1	6	9	6	6	12/1988	JAPAN			X
<i>EY</i>	2-	8	9	4	8	2		3/1990	JAPAN			X
<i>EY</i>	4-	3	8	0	4	9		2/1992	JAPAN			X
<b>OTHER DOCUMENTS</b> (Including Author, Title, Date, Pertinent Pages, Etc.)												
Examiner 					Date Considered <i>5/8/2002</i>							
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